

June 1989

# 5420/DM5420/DM7420 Dual 4-Input NAND Gates

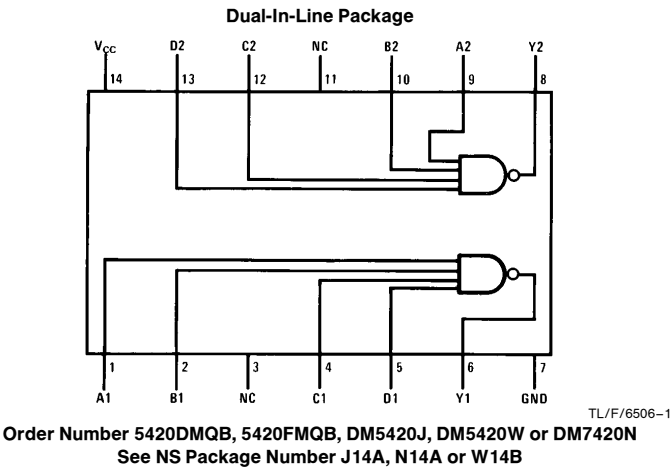
## General Description

This device contains two independent gates each of which performs the logic NAND function.

## Features

- Alternate Military/Aerospace device (5420) is available. Contact a National Semiconductor Sales Office/Distributor for specifications.

## Connection Diagram



## Function Table

$Y = \overline{ABCD}$

Inputs				Output
A	B	C	D	Y
X	X	X	L	H
X	X	L	X	H
X	L	X	X	H
L	X	X	X	H
H	H	H	H	L

H = High Logic Level  
L = Low Logic Level  
X = Either Low or High Logic Level

5420/DM5420/DM7420 Dual 4-Input NAND Gates

## Absolute Maximum Ratings (Note)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage	7V
Input Voltage	5.5V
Operating Free Air Temperature Range	
DM54 and 54	−55°C to +125°C
DM74	0°C to +70°C
Storage Temperature Range	−65°C to +150°C

Note: The “Absolute Maximum Ratings” are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the “Electrical Characteristics” table are not guaranteed at the absolute maximum ratings. The “Recommended Operating Conditions” table will define the conditions for actual device operation.

## Recommended Operating Conditions

Symbol	Parameter	DM5402			DM7402			Units
		Min	Nom	Max	Min	Nom	Max	
V <sub>CC</sub>	Supply Voltage	4.5	5	5.5	4.75	5	5.25	V
V <sub>IH</sub>	High Level Input Voltage	2			2			V
V <sub>IL</sub>	Low Level Input Voltage			0.8			0.8	V
I <sub>OH</sub>	High Level Output Current			−0.4			−0.4	mA
I <sub>OL</sub>	Low Level Output Current			16			16	mA
T <sub>A</sub>	Free Air Operating Temperature	−55		125	0		70	°C

## Electrical Characteristics over recommended operating free air temperature range (unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ (Note 1)	Max	Units
V <sub>I</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>I</sub> = −12 mA			−1.5	V
V <sub>OH</sub>	High Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OH</sub> = Max V <sub>IL</sub> = Max	2.4	3.4		V
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = Max V <sub>IH</sub> = Min		0.2	0.4	V
I <sub>I</sub>	Input Current @ Max Input Voltage	V <sub>CC</sub> = Max, V <sub>I</sub> = 5.5V			1	mA
I <sub>IH</sub>	High Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 2.4V			40	μA
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 0.4V			−1.6	mA
I <sub>OS</sub>	Short Circuit Output Current	V <sub>CC</sub> = Max (Note 2)	DM54 −20 DM74 −18		−55 −55	mA
I <sub>CCH</sub>	Supply Current with Outputs High	V <sub>CC</sub> = Max		2	4	mA
I <sub>CCL</sub>	Supply Current with Outputs Low	V <sub>CC</sub> = Max		6	11	mA

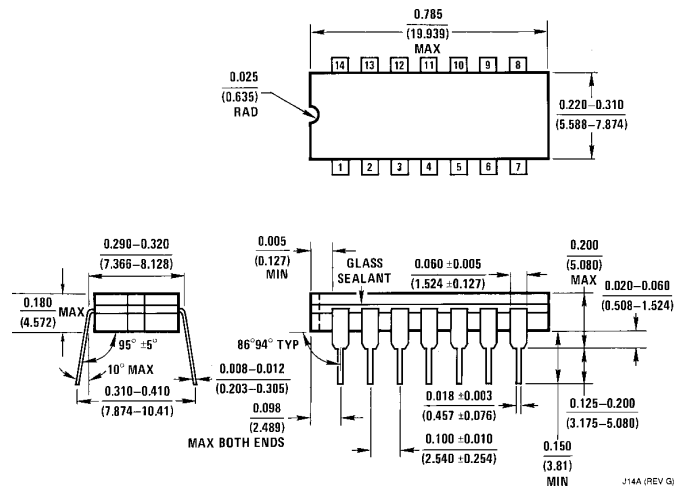
## Switching Characteristics at V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C (See Section 1 for Test Waveforms and Output Load)

Symbol	Parameter	Conditions	Min	Max	Units
t <sub>PLH</sub>	Propagation Delay Time Low to High Level Output	C <sub>L</sub> = 15 pF R <sub>L</sub> = 400Ω		22	ns
t <sub>PHL</sub>	Propagation Delay Time High to Low Level Output			15	ns

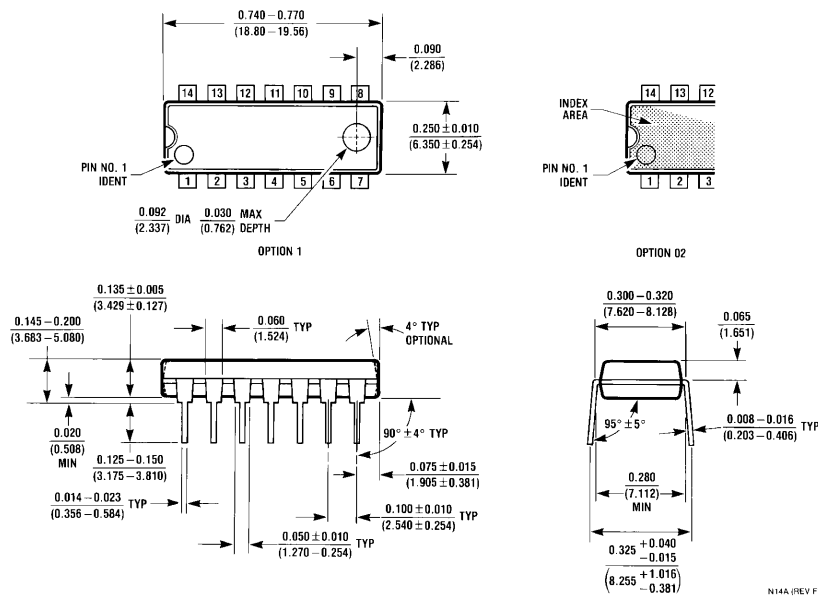
Note 1: All typicals are at V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C.

Note 2: Not more than one output should be shorted at a time.

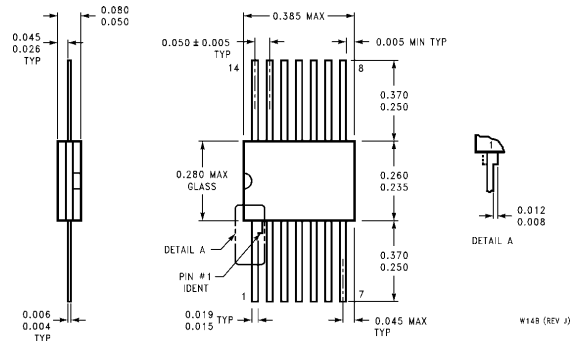
## Physical Dimensions inches (millimeters)



**14-Lead Ceramic Dual-In-Line Package (J)**  
**Order Number 5420DMQB or DM5420J**  
**NS Package Number J14A**



**14-Lead Molded Dual-In-Line Package (N)**  
**Order Number DM7420N**  
**NS Package Number N14A**

**Physical Dimensions** inches (millimeters) (Continued)

**14-Lead Ceramic Flat Package (W)**  
**Order Number 5420FMB or DM5420W**  
**NS Package Number W14B**

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